


<b>Search Notes</b> 	<b>Application/Control No.</b> 10568672	<b>Applicant(s)/Patent Under Reexamination</b> NISHIO, AKIHIKO
	<b>Examiner</b> NAM HUYNH	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
455	502, 447, 103, 67.1	6/18/2009	NTH

SEARCH NOTES		
Search Notes	Date	Examiner
See EAST search notes.	6/18/2009	NTH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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